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# LIST OF ART CITED BY APPLICANT

(PTO-1449)


 ATTY. DOCKET NO.  
MRE-0045.01

 APPLN. SERIAL NO.  
10/825,361

 APPLICANT(S)  
Ji Hyun HWANG, Do Hyun KIM and Sang Yeon HWANG

 FILING DATE  
4/16/2004

 GROUP  
1734

## U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE
TW	4,586,670	05/06/1986	Vancelette et al.			
TW	4,620,655	11/04/1986	Fujita			
TW	4,687,152	08/18/1987	Hawkswell			
TW	5,294,035	03/15/1994	Asai et al.			
TW	5,725,140	03/10/1998	Weber et al.			
TW	6,622,379	09/23/2003	Kano			
TW	6,671,946	01/06/2004	Kadota et al.			
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## U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

## U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

## FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No

## OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)


EXAMINER

/Timothy Waggoner/ (07/24/2006)

DATE CONSIDERED

<b>LIST OF PRIOR ART CITED BY APPLICANT</b> (PTO-1449)				ATTY. DOCKET NO. <b>MRE-0045.1</b>		CONTINUATION OF APPLN. SERIAL NO. <b>09/989,461</b>	
				APPLICANT(S) <b>Ji Hyun HWANG, Do Hyun KIM and Sang Yeon HWANG</b>			
				CUSTOMER NUMBER <b>34610</b>			
				FILING DATE <b>April 16, 2004</b>		GROUP <b>1734</b>	

  

<b>U.S. PATENT DOCUMENTS</b>			
<b>EXAMINER'S INITIALS</b>	<b>PATENT NO.</b>	<b>DATE</b>	<b>NAME</b>
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TW	4,763,811	08/16/88	Mae et al.
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<b>FOREIGN PATENT DOCUMENTS</b>							
<b>EXAMINER'S INITIALS</b>	<b>PATENT NO.</b>	<b>DATE</b>	<b>COUNTRY</b>	<b>CLASS</b>	<b>SUBCLASS</b>	<b>Translation</b>	
						Yes	No
TW	5-235589	09/10/93	Japan			X	

  

<b>OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)</b>	

  

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